

EXPRESS MAIL NO. EL411730165US

Docket No. 109A 2948

Date: March 17, 2000

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Hon. Commissioner of Patents and Trademarks Washington, D.C. 20231

Dear Sir:

Transmitted herewith for filing is the patent application for inventor(s): YONEZO FURUYA of Saitama, Japan

For: COIN INSPECTION METHOD AND APPARATUS THEREFOR

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8 sheet(s) of drawing	8 sheet(s) of drawings							
	Certified copy of Japanese Patent Application No. 71980/1999 (11-071980) of March 17, 1999 upon which Convention Priority is claimed							
Declaration and Power	Declaration and Power of Attorney							
Verified Statement Cla	Verified Statement Claiming Small Entity Status							
Information Disclosure	<u> X</u>							
Assignment of the inve	Assignment of the invention to							
KABUSHIKI KAISHA NIPPON CONLUX								
<u>For</u>	No. Filed	No. Extra			Basic Fee \$690/\$345			
Total Claims	<u>27</u> - 20	_7_	X	\$ 18/\$ 9	<u>\$ 126.00</u>			
Independent Claims	3 - 3	0	X	\$ 78/\$ 39	\$ 0			
Multiple Dependent Claims				\$260/\$130	\$			
Total Filing Fee					\$ 816.00			

The Commissioner is hereby authorized to charge any additional fees which may be required, or credit any overpayment to Account No. 11-1445. A duplicate copy of this sheet is enclosed.

A check in the amount of \$816.00 to cover the filing fee is enclosed.

X

A check in the amount of \$40.00 to cover the recordation of assignment is enclosed.

X

Respectfully submitted,

KODA & ANDROLIA

10100 Santa Monica Boulevard **Suite 2340** Los Angeles, CA 90067 (310) 277-1391 -tel (310) 277-4118 -fax

William L. Androlia Reg. No. 27,177





I hereby certify that this correspondence is being deposited with the United States Postal

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Hon. Commissioner of Patents and Trademarks Washington, D.C. 20231

on March 17, 2000 by Kimberly A. Quinlan

Dated: Man CX 13 Lovo

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AIWA

Inventor:

YONEZO FURUYA

For:

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